



# TECHNICAL REPORT



**Measurement procedure for the evaluation of power density related to human exposure to radio frequency fields from wireless communication devices operating between 6 GHz and 100 GHz**

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

# MEASUREMENT PROCEDURE FOR THE EVALUATION OF POWER DENSITY RELATED TO HUMAN EXPOSURE TO RADIO FREQUENCY FIELDS FROM WIRELESS COMMUNICATION DEVICES OPERATING BETWEEN 6 GHz AND 100 GHz

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